

Enhanced Deep Learning Approach Based on the Deep Convolutional Encoder–Decoder Architecture for Electromagnetic Inverse Scattering Problems

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Abstract—This letter proposes a novel deep learning (DL) approach to resolve the electromagnetic inverse scattering (EMIS) problems. The conventional approaches of resolving EMIS problems encounter assorted difficulties, such as high contrast, high computational cost, inevitable intrinsic nonlinearity, and strong ill-posedness. To surmount these difficulties, a novel DL approach is proposed based on a novel complex-valued deep fully convolutional neural network structure. The proposed complex-valued deep learning model for solving EMIS problems composes of an encoder network and its corresponding decoder network, followed by a final pixel-wise regression layer. The complex-valued encoder network extracts feature fragments from received scattered field data, while the role of the complex-valued decoder network is mapping the feature fragments to retrieve the final contrasts (permittivities) of dielectric scatterers. Hence, the proposed deep learning model functions as an “heterogeneous” transformation process, where measured scattering field data is converted into the corresponding contrasts of scatterers. As a consequence, the EMIS problem could be resolved accurately even for extremely high-contrast targets. Numerical benchmarks have illustrated the feasibility and accuracy of our proposed approach. The proposed approach opens a novel path for the deep learning-based real-time quantitative microwave imaging for high-contrast scatterers.

Index Terms—Convolutional neural network, deep learning (DL), electromagnetic inverse scattering (EMIS), high-contrast scatterer.

I. INTRODUCTION

THE electromagnetic inverse scattering (EMIS) has been referred to as the most effective tool for microwave imaging [1], [2]. Its objective is to obtain image of the scatterers from the measured scattering field information [1]–[3]. Thus, solving EMIS problem only requires the received field data outside

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the target medium. Because of its noncontact and nondestructive characteristics for detection, EMIS has been extensively employed in medical imaging and civil measurement [4]–[6]. Since the last few decades, a lot of modeling approaches have been proposed to resolve the EMIS problem, including Born iterative method (BIM) [7], contrast source inversion [8], [9], contrast-source extend Born [10], and subspace optimization method [11]. Unfortunately, nearly all conventional modeling methods for solving EMIS problem are limited by the avoidable ill-posedness [1]–[3]. High-contrast scatterers also challenge the application of these conventional methods due to the low precision [1]–[3], [7]–[11]. Besides, the high computational complexity and time resulting from these conventional optimization methods can never fulfill the requirement of realizing the microwave imaging for high-contrast scatterers in real time. Finally, the necessary EM coupled equations for conventional methods cannot be independent on the complex Green’s functions, which have to be specifically constructed according to the practical application scenarios [12], [13].

Deep learning (DL) is rapidly developing in every corner of the modern computational science [14], [15]. It is promoting the development of conventional computational electromagnetics. There have been a large number of representative applications, involving scientific computation [16]–[18], remote sensing imaging [19], [20] and hybrid field-circuit simulation [21], [22]. In fact, machine learning has been employed in the EMIS problem. The artificial neural network has been utilized to resolve the EMIS problem in [23], [24]. Unfortunately, these approaches are greatly limited to specific application scenarios, where the methods are only valid for scatterers with a set of specific parameters pattern [23], [24]. Recently, a number of works based on DL techniques have been applied to EM problems [25]–[36], including solving the forward EM problems and the EMIS problems. In [25]–[27], the DL approaches are used to offer relatively better performance. At present, these DL-based methods are partially dependent on the conventional methods and need to use the initial inputs provided by traditional methods to conduct further operation, such as initial inputs from the backpropagation method [37]. Moreover, although some previous works have introduced DL into solving the EMIS problem and obtained better performance than the conventional methods [29], the application of representative two-step cascaded DL method increases the computational complexity of solving the EMIS problem.

In this letter, we propose a novel DL method based on the deep convolutional encoder–decoder structure to resolve EMIS problems. The model is constructed on the complex-valued

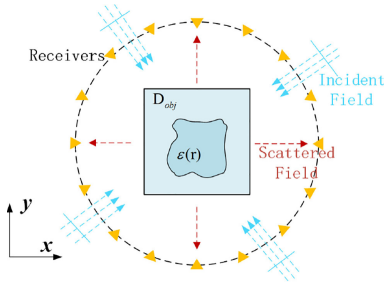


Fig. 1. TM_z wave scattering for the region D_{obj} .

deep convolutional neural network (DConvNet), consisting of an encoder network and its corresponding decoder network. It can effectively reconstruct the permittivity (contrast) “images” of dielectric objects from the received scattered field information. The advantages of the proposed approach are as follows.

- 1) Effectiveness: The new DL approach can effectively work on the high-contrast scatterers, compared to the conventional methods.
- 2) Simplicity: The DL framework can avoid calculating complicated Green’s functions to reduce the high complexity of the traditional approaches.
- 3) Accuracy: The accuracy of the proposed method is much higher than the conventional methods.

II. THEORY AND FORMULATION

A. Problem Formulation

Fig. 1 presents the representative schematic of EMIS, where an object domain D_{obj} is surrounded by M equally spaced receivers. The object dielectric domain D_{obj} is gridded into uniform $N \times N$ fragments and is illuminated by the TM_z incident field E^{in} . The scattered field measured by M receivers is denoted as E^s . While this 2-D configuration is employed to illustrate the mechanism of our approach, we emphasize our approach can also be employed to 3-D configuration. To formulate the whole process of the EMIS, two governing equations are introduced in (1) and (2), which are also called Lippmann–Schwinger equations [38].

The first formula for the EMIS mainly formulates the interaction among the field of scatterer pieces in D_{obj} , as in

$$E^{in}(\mathbf{r}) = E^t(\mathbf{r}) - k_0^2 \int_{D_{obj}} G(\mathbf{r}, \mathbf{r}') \chi(\mathbf{r}') E^t(\mathbf{r}') d\mathbf{r}' \quad (1)$$

where $G(\mathbf{r}, \mathbf{r}')$ is denoted as the Green’s function and we have $G(\mathbf{r}, \mathbf{r}') = -\frac{j}{4} H_0^{(2)}(k_0 |\mathbf{r} - \mathbf{r}'|)$ for 2-D TM_z wave. $H_0^{(2)}$ is the second kind zeroth order Hankel function while k_0 is the wave number in the free space. $\mathbf{r}' = (x', y')$ and $\mathbf{r} = (x, y)$ stands for the source and field points in object domain D_{obj} , respectively. While E^t stands for the total electric field, the contrast function can be denoted to be $\chi(\mathbf{r}') = \epsilon_r(\mathbf{r}') - 1$.

Based on (1), the scattered field is described as the reradiation by the total field E^t in scatterers, and the relationship between E^s and E^t is shown as follows:

$$E^s(\mathbf{r}) = k_0^2 \int_{D_{obj}} G(\mathbf{r}, \mathbf{r}') \chi(\mathbf{r}') E^t(\mathbf{r}') d\mathbf{r}' \quad (2)$$

where $\mathbf{r} = (x_R, y_R)$ stands for the coordinate of the receivers, whereas $\mathbf{r}' = (x', y')$ is on the source piece in D_{obj} .

The final target of the EMIS problem is to retrieve the contrast χ (or permittivity ϵ_r) of the scatterer by using the scattered field received by M receivers around the D_{obj} . Directly solving the coupled (1) and (2) to retrieve the contrast is very hard [1], [3]. Usually, the conventional methods construct an objective function $f(\chi)$, as shown in (3), and attempt to retrieve contrast by optimization methods [3].

$$\min : f(\chi) = \sum_{i=1}^{N_i} \|E_i^s - E_i^s(\chi)'\|^2 + \alpha T(\chi) \quad (3)$$

where the received scattering field E_i^s is induced by N_i separate incident field E^{in} onto D_{obj} , and the optimized scattering fields $E_i^s(\chi)'$ approaches the measured scattered field E_i^s by iterative optimization computation in (3). $\|\cdot\|$ is the Euclidian length, whereas T is denoted as the regularization for balancing data fitting and the solution stability [27], [39].

In the conventional methods, the (1) and (2) are first transformed into the following discretized coupled equations [1], [3] for the optimization process in (3), where the object domain D_{obj} is gridded into uniform pieces, and the contrast and the total electric field of each individual piece are treated as the piecewise constant

$$\bar{E}^s = \bar{G}_R \cdot \text{diag}(\bar{E}^t) \cdot \bar{\chi} \quad (4)$$

$$\bar{E}^{in} = \bar{E}^t - \bar{G}_D \cdot \text{diag}(\bar{E}^t) \cdot \bar{\chi} \quad (5)$$

where the size of the matrices \bar{G}_R and \bar{G}_D are $M \times N^2$ and $N^2 \times N^2$, respectively. We have $\bar{G}_R = k_0^2 S_{n'} G(\mathbf{r}_{n_r}, \mathbf{r}_{n'})$ and $\bar{G}_D = k_0^2 S_{n'} G(\mathbf{r}_n, \mathbf{r}_{n'})$, where $S_{n'}$ is the area of source piece. We also have $n_r = 1, \dots, M$, $n = 1, \dots, N^2$, and $n' = 1, \dots, N^2$.

Unfortunately, solving (3) by conventional optimization methods also face challenges due to its nonlinearity [1], [3], particularly for high contrast situations [1], [3].

B. Encoder–Decoder Structure for EMIS

To solve the problem of the high-contrast scatterers with high accuracy, a novel DL approach is proposed based on the DConvNet. In the novel approach, the deep convolutional encoder–decoder structure is employed to transform original scattering fields into the contrasts (permittivities) of scatterers in the objective region. Considering the difficulties of collecting the huge number of training samples by real experiments, the simulation data are applied to train DL models.

The proposed DConvNet is revised based on the structure of SegNet [40] that has been widely employed for the image segmentation. Typical ConvNets [41], [42] comprises of five different kinds of layer unit: input layers, convolutional layers, activation layers, pooling layers, and fully connected layers. The typical ConvNet architecture is constructed based on these layer unit. In this work, these typical layers are stacked together to design the proposed DConvNet to solve the EMIS problem.

The specific internal structure of our DConvNet is presented in Fig. 2. Its input is the scattering field E^s , referred to as “field data,” which is the matrix with the size of the $M \times N_i \times 2$. M represents M receivers and N_i is the total number of the incident

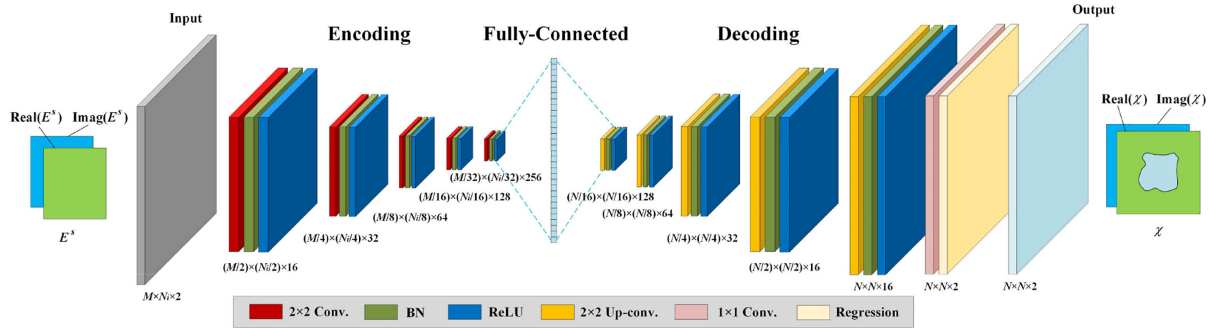


Fig. 2. DConvNet architecture. Conv. is convolution, BN is batch normalization, ReLU is rectified linear unit, whereas Up-conv. represents up-convolution.

field, whereas the real and imaginary parts of E^s stand for its two tubes, which is presented in Fig. 2. Meanwhile, its output is a $N \times N \times 2$ matrix comprising of the real and imaginary parts of the target permittivity.

In the DConvNet, the designed convolutional and activation layers in encoding part act to capture features of input. The parameters, including the convolutional layer number, the filter (kernel) number and its size, etc., are also shown in Fig. 2 [41], [42]. Then, the decoding part feeds into a final regression layer, which finally provides the prediction of the contrast χ . This prediction is denoted as the final output of the DConvNet. The loss function is the so-called half-mean-squared error between these predicted responses of each pixel and the true label, as in (6).

$$\text{loss} = \frac{1}{2} \sum_{p=1}^{HWC} (t_p - y_p)^2 \quad (6)$$

where H , W , and C are set as the height, width, and channel number of the final output. p indexes into each pixel of the target t and the prediction y .

In Fig. 2, the designed DConvNet mainly involves three parts: encoding, decoding, and fully connected. The first part encodes “field data” E^s layer by layer and refines it into chunks of information fragments, whereas the corresponding decoding part reorganizes the extracted information fragments layer by layer until the final scatterer contrast χ is generated. The middle fully connected intermediate part can be seen as the bridge linking the encoding and decoding parts. In detail, the encoding part consists of repeated applications of 2×2 convolution with its stride equal to 2, rectified linear unit (ReLU) and batch normalization (BN). Comparatively, the corresponding decoding part composes of the repeated applications of 2×2 up-convolution with its stride equal to 2, BN and ReLU operations, whereas a 1×1 convolution layer and the regression layer are set at the end of this part, as presented in Fig. 2. The selection of parameters and the detailed operation in those layers can refer to [25]–[27], [29], [41]–[44]. Generally, 2×2 filter in convolutional layers can decrease the parameter number on filter, while the stride 2 can increase or decrease the size of the middle layers for encoding and decoding parts [29], [40], [44]. The nonlinear relation between input and output is denoted as the following formula, while Γ is denoted as the nonlinear operation of the proposed DL model:

$$\chi = \Gamma(E^s). \quad (7)$$

The entire process is summarized as a “heterogeneous” process. It transforms received scattering field into the final contrast

of the target scatterers. In the process, the complex-valued DConvNet directly uses E^s as the input, while the output is chosen as χ . Hence, the proposed complex-valued DConvNet entirely replaces the conventional methods and complete all their operations, i.e., the initial contrast selection and the later operation processes [7]–[11]. Besides, we highlight that the whole process of constructing model is independent on the calculation of Green’s function, and it can reduce the ill-posedness of the conventional methods [7]–[11], thanks to its the data-driven characteristics, which are based on the training to obtain more prior knowledge [29], [30]. Moreover, we emphasize that the proposed DConvNet can completely finish the reconstruction operation by one model, which is simpler than the two-step approach [29]. Finally, unlike [27], [29], [43], [44], the proposed DConvNet directly finishes the “heterogeneous” transformation from scattering field to contrast by encoder–decoder structure and does not need the skip connection in the U-Net to realize the residual learning.

The newly proposed DConvNet model is implemented into MATLAB 2019a with the DL Toolbox [45]. Adaptive moment estimation (Adam) optimizer is used for optimizing the above-mentioned loss function. Compared with other optimizers, including stochastic gradient descent, Adam optimizer generally navigates through the loss surface more favourably [46], [47].

There are several issues about the above-mentioned proposed model that need to be emphasized.

- 1) *Fully connected intermediate layer*: Unlike the conventional encoder–decoder structure in SegNet [40], fully connected intermediate layer is added between the encoding part and decoding part in our DConvNet. By the operation of the fully connected intermediate layer, the information fragments extracted from encoding part are reorganized into the new feature maps and are further transformed into the final output. The added fully connected intermediate layer effectively increases the capacity of converting “heterogeneous” features from field into contrast.
- 2) *Complex-valued input and output*: As a representative complex-valued problem, both the received electronic field and the contrast of the object domain are complex valued for the EMIS problem. Thus, the original channel number of both input and output of the SegNet has to be revised [40], so that their real and imaginary parts could be adapted in the different channels. Hence, the novel model can be more adaptable and flexible for reconstructing contrast in real situations.

3) *Computational complexity*: For the proposed DConvNet, the computation mainly depends on the repetitive application of convolutions, BN and ReLU, where the filter kernel is tiny in the DConvNet and its operation count is mainly dominated by convolution operation [27], [43]. For the encoder part, the network has the input with the size of $M \times N_i \times 2$, R filters with the size of $K \times K$ each layer and f layers. Thus, its computation complexity of the DConvNet is $O(MN_iK^2R^2f)$ [44], [48]. Moreover, the computation of the decoding part can be treated as the same operation of encoding part but from the opposite direction. Thus, with all similar hyperparameters, including filter number and size, etc., only the size of output (equivalent to the input of encoding part) is replaced by $N \times N \times 2$. Thus, the computational complexity of decoding part is $O(N^2K^2R^2f)$. Generally, we tend to choose the size of input field “image” to be approximated to the size of output contrast “image”, which has also been done in [27], [29], [44]. Hence, the computational complexity of the entire network can be approximated to $O(N^2K^2R^2f)$ [44], [48]. Besides, its storage mainly depends on the size of the filters and biases. Thus, the storage of our DConvNet is $O(K^2R^2f)$ [44], [48].

III. NUMERICAL EXAMPLES

To validate the precision and effectiveness of the newly proposed DL approach, we use the popular MNIST dataset as the target scatterers samples [25]–[27]. The size of each sample in MNIST dataset is set to about $2.25 \lambda \times 2.25 \lambda$ (the wavelength $\lambda = 1$ m in free space) and is gridded into 32×32 uniform pieces (i.e., $N = 32$). While 32 receivers ($M = 32$) are uniformly set around D_{obj} with the distance 30λ , the TM_z incident plane waves come from 32 different directions to impinge on the object domain D_{obj} with the incident angles uniformly distributed within $[0^\circ, 360^\circ)$, (i.e. $N_i = 32$). In this section, the full-wave EM simulations [49] are employed for all samples to create both training and testing dataset. More details about the similar numerical setup can refer to [25]–[29], [43], [44]. By using the MNIST dataset, the digit-shaped scatterers are given the extremely high relative permittivity $\varepsilon_r = 8$, which is the much challenging task for the conventional methods. A total of 8000 samples in MNIST dataset are randomly chosen to train the proposed DL model, whereas another 1000 samples are employed for testing. Two quantitative indicators, i.e., normalized mean-square error (NMSE) and structural similarity index (SSIM), are employed to evaluate the result of retrieved “images”, as what has been done in [25]–[27]. Moreover, the BIM is applied to retrieve the permittivities of the testing samples for comparison. The results are shown in Fig. 3.

Fig. 3 demonstrates the comparisons among the ground truths, reconstructed images of BIM, and the reconstructed results of the DConvNet approach. Evidently, the final reconstruction outputs of the proposed method have good agreements with the ground truth. However, for these high-contrast cases, the BIM never offers any acceptable result.

In Fig. 4, the statistical analyses for the testing results are presented: the NMSE average of reconstructed results obtained by the DConvNet is around 0.08, and the SSIM average obtained from the proposed approach can reach around 0.8. Therefore, the

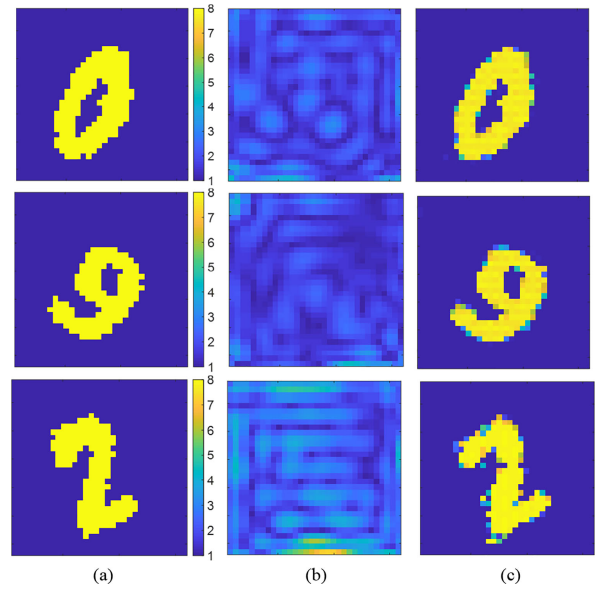


Fig. 3. Comparisons of reconstructed relative permittivities of digit-shaped scatterers. (a) Ground truth. (b) Reconstructed relative permittivities of the BIM. (c) Reconstructed relative permittivities of the proposed DConvNet. (The third row presents the relative bad reconstruction results.)

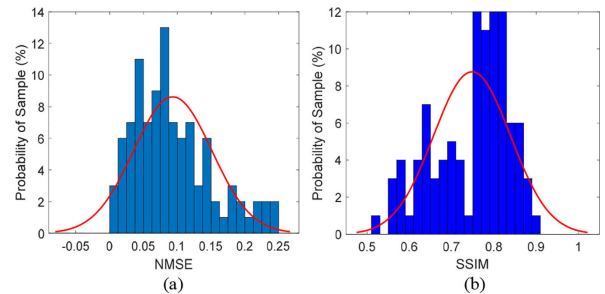


Fig. 4. Statistical histograms of the image quality for the reconstructed permittivities and fitting of its normal density function. (a) NMSE results from the DConvNet method. (b) SSIM results from the DConvNet method.

newly proposed DL method can resolve the EMIS problem with excellent performances.

IV. CONCLUSION

A novel DL approach based on the complex-valued DConvNet structure is proposed to resolve the EMIS problems. The traditional methods are challenged by various difficulties, including high-contrast case and the ill-posedness. The proposed complex-valued DL model comprises of a complex-valued convolutional encoder–decoder architecture. The encoder network extracts feature fragments from measured scattering field data, whereas decoder network then reorganizes the feature fragments to retrieve the final reconstructed contrasts of scatterers. As a result, the EMIS problems can be resolved with high precision even for extremely high-contrast scatterers. Numerical benchmarks illustrate the validity of this DL approach. The proposed DL method for the EMIS problem offers a novel tool to realize the quantitative microwave imaging in real time.

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